

S72	76	(nano\$1probe (nano adj probe)) same (substrate material \$5film coat\$3 layer sheet pad wafer film lamina level plane)	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2005/08/08 13:06
S73	66	S72 and @ad<"20030922"	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2005/03/23 15:23
S74	7	S73 and ((project\$5 protrud\$5 extend\$5) near2 (portion part member moiety parcel piece section segment))	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2005/08/08 13:16
S75	3	S74 and (conduct\$5 near2 (wir\$3 cord\$3 cabl\$3 line link channel connect\$5 lead\$3))	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2005/03/23 15:27
S76	1	(324/724.ccls.) and @ad<"20030922" and @pd>"20050316"	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2005/08/08 11:21
S77	4	(324/722,691.ccls.) and @ad<"20030922" and @pd>"20050316"	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2005/08/08 11:21
S78	4	(324/649,600.ccls.) and @ad<"20030922" and @pd>"20050316"	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2005/08/08 11:21
S79	82	(324/751,752,754,755,757,758.ccls.) and @ad<"20030922" and @pd>"20050316"	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2005/08/08 11:22

S80	162	(324/72.5,715,765,158.1.ccls.) and @ad<"20030922" and @pd>"20050316"	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2005/08/08 11:22
S81	3	(324/437,445-447.ccls.) and @ad<"20030922" and @pd>"20050316"	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2005/08/08 11:22
S82	1	(324/690,696.ccls.) and @ad<"20030922" and @pd>"20050316"	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2005/08/08 11:53
S83	69	(nano\$1probe (nano adj probe)) same (substrate material \$5film coat\$3 layer sheet pad wafer film lamina level plane) and @ad<"20030922"	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2005/08/08 13:39
S84	7	S83 and ((project\$5 protrud\$5 extend\$5) near2 (portion part member moiety parcel piece section segment compartment component assembly unit tool))	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2005/08/08 13:39
S85	168	(nano\$1probe (nano adj probe)) and @ad<"20030922"	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2005/08/08 14:42
S86	33	S85 and ((project\$5 protrud\$5 extend\$5) near2 (portion part member moiety parcel piece section segment compartment component assembly unit tool))	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2005/08/08 13:40
S88	1462	(600/11,459,462.ccls.) and @ad<"20030922"	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2005/08/08 14:25

S89	807	(600/372,373,393.ccls.) and @ad<"20030922"	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2005/08/10 09:16
S90	2	("20050062488").PN.	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2005/08/08 14:35
S91	0	S88 and (nano\$1probe (nano adj probe))	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2005/08/08 14:42
S92	0	S89 and (nano\$1probe (nano adj probe))	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2005/08/08 15:02
S93	1	((((nano\$1probe (nano adj probe)) and (project\$5 protrud\$5 extend\$5) and (substrate material \$5film coat\$3 layer sheet pad wafer film lamina level plane) and (portion part member moiety parcel piece section segment compartment component assembly unit tool) and (plural\$5 number multipl\$5 series several set) and conduct\$5).clm.) and @ad<"20030922"	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2005/08/08 15:07
S94	0	((((nano\$1probe (nano adj probe)) and (project\$5 protrud\$5 extend\$5) and (substrate material \$5film coat\$3 layer sheet pad wafer film lamina level plane) and (portion part member moiety parcel piece section segment compartment component assembly unit tool) and (plural\$5 number multipl\$5 series several set) and conduct\$5 and (flexible conformable adaptable adjustable bendable tractable moldable stretchable elastic extensible) and (stiff\$4 rigid\$5 \$2flexib\$5)).clm.) and @ad<"20030922"	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2005/08/10 09:25
S95	297721	\$5probe and @ad<"20030922"	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2005/08/10 09:17

S96	3762	S95 and ((project\$5 protrud\$5 extend\$5) near2 (portion part member moiety parcel piece section segment)) same (stiff\$4 rigid\$5 \$2flexib\$5)	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2005/08/10 09:20
S97	798	S95 and ((project\$5 protrud\$5 extend\$5) near2 (portion part member moiety parcel piece section segment)) near3 (stiff\$4 rigid\$5 \$2flexib\$5)	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2005/08/10 09:22
S98	496	S97 and (electrode plate contact pole tip probe) with (flexib\$5 conformable adaptable adjustable bendable tractable moldable stretchable elastic extensible)	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2005/08/10 09:23
S99	345	S97 and (electrode plate contact pole tip probe) near3 (flexib\$5 conformable adaptable adjustable bendable tractable moldable stretchable elastic extensible)	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2005/08/10 09:23
S100	61	S99 and (plural\$5 number multipl\$5 series several set) near3 conduct\$5	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2005/08/10 09:26
S101	2	("6788086").PN.	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2005/08/17 13:33